

# Technical Programme

Tuesday 2nd September 2008

## Conference Opening Plenary

Baroness Tessa Blackstone, Chancellor of the University of Greenwich  
William Chen, President of IEEE CPMT

## Keynote: Ambient Assisted Living

## Coffee Break

## Technical Papers in Parallel Sessions

### Session Tu-A-1 Poster Session : Manufacturing and Test Technology

#### Replacement of vias with polymer thick film pastes (PTF) for the use on flexible substrates

Markus Detert, Michael Zeise, Klaus-Jürgen Wolter, Dresden University of Technology / Center of microtechnical Manufacturing

#### Chosen electrical and stability properties of laser-shaped thick-film and LTCC inductors

Andrzej DZIEDZIC<sup>1</sup>, Maciej BAK<sup>1</sup>, Marcin DUDEK<sup>1</sup>, Jaroslaw KITA<sup>2</sup>: Wroclaw University of Technology, Faculty of Microsystem Electronics and Photonics, <sup>2</sup>University of Bayreuth, Functional Materials Group

#### An Investigation of Electroless Copper Films Deposited on Glass

Xiaoyun Cui, David Hutt, Paul Conway, Loughborough University

#### Micro-fabrication on 3-D surface by Electrostatic Induced Lithography

Weixing Yu, Marc Desmulliez, Mark Leonard, Cargill Scott, Heriot-Watt University

#### Influence of special cleaning compounds on PCBs solderability

Petr Harant<sup>1</sup>, Jiri Sary<sup>2</sup>, Frantisek Steiner<sup>1</sup>, Petr Stejska<sup>2</sup>: University of West Bohemia, <sup>2</sup>Brno University of Technology

#### VPS Solution for Lead-Free Soldering in EMS Industries

PLOTOG Ioan<sup>1</sup>, VARZARU Gaudentiu<sup>2</sup>, TURCU Carmen<sup>2</sup>, CUCU Traian Cornel<sup>3</sup>, SVASTA Paul<sup>1</sup>, CODREANU Norocel Dragos<sup>1</sup>: <sup>1</sup>UPB-CETTI, <sup>2</sup>INTRAROM SA, <sup>3</sup>BRADY

#### Automated Optical Inspection Tool Using the LPKF PCB Mechanical Prototyping Machine Manufacturing

Muresan Marius Valentin, Pitica Dan, Chindris Gabriel, Technical University of Cluj-Napoca

#### Testing of Techniques for Improvement of Conductivity of Electrically Conductive Adhesives

Pavel Mach<sup>1</sup>, Lukáš Richter<sup>1</sup>, Alena Pietriková<sup>2</sup>: Czech Technical University in Prague, Prague, Czech Republic, <sup>2</sup>Technical University in Košice, Košice, Slovakia

#### Trace faults detection and current density verification on a PCB using digital image processing

Stefan Oprea, Ioan Lita, Ion Bogdan Cioc, Daniel Alexandru Visan, University of Pitesti

#### Electronic Equipment For Temperature Measuring And Controlling With Geothermal Applications

Horia Carstea, Romeo Negrea, Paul Constantinescu, Daniela Samoila-Mihet, University Politehnica of Timisoara

### Session Tu-A-2 Advanced Packaging—3D Integration and Assembly

#### Through Silicon Via Interconnection Technology for ISM Wafer Level Chip Scale Package

Chang-Hyun Lim, Won-Kyu Jeung, Jing-li Yuan, Seung-Wook Park, Seog-Moon Choi, Sung Yi, Samsung Electro-Mechanics

#### Fabrication and Electrical Characterization of Through Silicon Via Interconnection by Room Temperature Bonding

Tanaka Naotaka<sup>1</sup>, Kawashita Michihiro<sup>1</sup>, Yoshimura Yosuihiro<sup>1</sup>, Uematsu Toshihide<sup>2</sup>, Fujisawa Masahiko<sup>2</sup>, Naito Takahiro<sup>2</sup>, Kikuchi Takafumi<sup>2</sup>, Akazawa Takashi<sup>2</sup>: Hitachi, Ltd., <sup>2</sup>Renesas Technology

#### Characterization of interconnects resulting from capillary die-to-substrate self-assembly

Massimo Mastrangeli<sup>1</sup>, Jean-Pierre Celis<sup>1</sup>, Wouter Ruythooren<sup>2</sup>, Chris Van Hoof<sup>2</sup>: IMEC/Katholieke Universiteit Leuven, <sup>2</sup>IMEC

#### Wafer Level Packaging Technology Development For Cmos Image Sensors Using Through Silicon

Jean Charbonnier, David Henry, Fabrice Jacquet, Bernard Aventurier, Cathy Brunet-manquat, Grégory Enyedi, Nicole Bouzaida, Valérie Lapras, Nicolas Sillon, CEA-LETI-MINATEC

## Session Tu-A-3 New Materials and Processes : Materials Applications

### Laser Processing of Materials for MCM-C Applications

Jaroslav Kita, Egmont Gollner, Ralf Moos, University of Bayreuth /Functional Materials Lab

### Determination of mechanical properties of small test volumes using nanoindentation – a critical review

Wolfgang H. Müller<sup>1</sup>, Alexander Haese<sup>1</sup>, Jens Sterthaus<sup>1</sup>, Jürgen Villain<sup>2</sup>, Christina Weippert<sup>2</sup>, Ulrike Corradi<sup>2</sup>, Usman Saeed<sup>2</sup>

<sup>1</sup>Technische Universität Berlin, <sup>2</sup>University of Applied Sciences Augsburg

### 50-70GHz Microstrip Ultra-wideband Bandpass Filter on Liquid Crystal Polymer Substrate

Xia Zhang<sup>1</sup>, Johan Liu<sup>1</sup>, Dan Kuylenstierna<sup>2</sup>, Herbert Zirath<sup>2</sup> <sup>1</sup>Chalmers University and Technology & Shanghai University,

<sup>2</sup>Chalmers University and Technology

### Die-Level Integration Of Metal MEMs With CMOS

Anisha Goswami Mukherjee, Michail E Kiziroglou, Andrew S Holmes, Eric M Yeatman, Department of Electrical and Electronic Engineering, Imperial College, London

## Session Tu-A-4 Modelling, Simulation and Design : Simulation and DFR

### Sn3.0Ag0.5Cu Solder Joints Lifetime Estimation for Electronic Assemblies under Random Vibration

Marc GRIEU, Gregor MASSIOT, Olivier MAIRE, EADS France

### A Mobile WiMAX RF Front-end Module with Integrated Passive Components and Novel Material

Wei-Ting Chen, Chang-Sheng Chen, Chang-Lin Wei, Cheng-Hua Tsai, Kuo-Chiang Chin, Industrial Technology Research Institute

### Warpage Control of WL-CSP for Memory Application

Jupyo Hong, Gao Shan, Seoungwook Park, Jonghwan Baek, Seogmoon Choi, Sung Yi, Samsung Electro-Mechanics

### Modelling and Prototyping the Conceptual Design of 3D CMM Micro-probe

Stoyan Stoyanov<sup>1</sup>, Chris Bailey<sup>1</sup>, Richard Leach<sup>2</sup>, Ben Hughes<sup>2</sup>, Alan Wilson<sup>2</sup>, William O'Neill<sup>3</sup>, Robert Dorey<sup>4</sup>, Christopher Shaw<sup>4</sup>, Daniel Underhill<sup>4</sup>.

<sup>1</sup>University of Greenwich, <sup>2</sup>National Physical Laboratory, <sup>3</sup>University of Cambridge, <sup>4</sup>Cranfield University

## Session Tu-A-5 Manufacturing and Test Technology : Test I

### In-Situ Temperature Monitoring for Process Control in Laser Assisted Polymer Bonding for MEMS Packaging

Yufei Liu, Jun Zeng, Changhai Wang, School of Engineering and Physical Sciences, Heriot Watt University

### Contactless measurement of conductivity of doped GaAs using compact microwave instrument

Yang Ju, Nagoya University

### Development of an in-situ, non-destructive Ultrasonic Monitoring Technique for Solder Pastes

Anton Seman<sup>1</sup>, Ndy N. Ekere<sup>1</sup>, Sabuj Mallik<sup>1</sup>, Antony E. Marks<sup>1</sup>, Rajkumar Durairaj<sup>2</sup> <sup>1</sup>University of Greenwich at Medway/ Electronic

Manufacturing Engineering Research Group, <sup>2</sup>Universiti Tunku Abdul Rahman (UTAR)

### Improved infra-red (IR) microscope measurements for the micro-electronics industry

C.H. Oxley, R.H. Hopper, G.A. Evans, DeMontfort University

## Session Tu-A-6 Power Electronics : Design

### A Systematic Design Approach to Thermal-Electrical Power Electronics Integration

Didier Cottet<sup>1</sup>, Uwe Drofenik<sup>2</sup>, Jean-Marc Meyer<sup>3</sup> <sup>1</sup>ABB Switzerland Ltd., Corporate Research, <sup>2</sup>ETH Zürich, Power Electronic Systems Laboratory, <sup>3</sup>ABB Switzerland Ltd.

### Modelling and simulation of simple mechatronic system – position control solution based on linear variable inductor displacement transducer

Andrei Drumea<sup>1</sup>, Alexandru Vasile<sup>1</sup>, Paul Svasta<sup>1</sup>, Ioana Ilie<sup>2</sup> <sup>1</sup>Politehnica University Bucharest, <sup>2</sup>Research Institute for Hydraulics and Pneumatics INOE2000-IHP

### Real-Time Life Expectancy Estimation in Power Modules

Mahera Musallam<sup>1</sup>, Mark Johnson<sup>1</sup>, Chunyan Yin<sup>2</sup>, Hua Lu<sup>2</sup>, Chris Bailey<sup>2</sup> <sup>1</sup>University of Nottingham, <sup>2</sup>University of Greenwich

### Thermal Impact of Randomly Distributed Solder Voids on Rth-JC of MOSFETs

Liu Chen, Mervi Paulasto-Kröckel, Ulrich Fröhler, Dirk Schweitzer, Heinz Pape, Infineon Technologies AG

## Session Tu-A-7 Electronics System Integration for Healthcare : Materials

### Implantable Packaging Technique Featuring Through Wafer Interconnects and Low Temperature Direct Bond

James Lee, Applied Microengineering

### Investigation of thick film electronic packaging materials in dynamic contact with artificial body fluids

Natalia Beshchasna, Eberhard Engelen, Jürgen Uhlemann, Klaus-Jürgen Wolter, Electronic Packaging Laboratory, Technische Universität Dresden

### Property Evaluations of Polymers used as Housing Material for Passivation of Electronic Devices

Eberhard Engelen<sup>1</sup>, Natascha Beshchasna<sup>1</sup>, Markus Braunschweig<sup>2</sup>, Jürgen Uhlemann<sup>1</sup>, Klaus-Jürgen Wolter<sup>1</sup>, <sup>1</sup>Elektronics Packaging Laboratory, Department of Electrical Engineering and Information Technology, Technische Universität Dresden, Germany,

<sup>2</sup>Microelectronic Packaging Dresden GmbH, Germany

### Biocompatible DC-Microelectrode Array

Jonathan Derix<sup>1</sup>, Gerald Gerlach<sup>1</sup>, Richard Funk<sup>2</sup>, Susanne Wetzel<sup>2</sup> <sup>1</sup>Technische Universität Dresden, Solid State Electronics Lab, Dresden, Germany, <sup>2</sup>Technische Universität Dresden, Department of Anatomy, Dresden, Germany

## Lunch Break

### Session Tu-P-8 Poster Session : Modelling, Simulation and Design & Reliability and Technology for Micro and Nano Systems

**Reliability Modeling & Test For Flip-Chip On Flex Substrates With Ag-Filled Anisotropic Conductive Adhesive**  
Bernhard Wunderle<sup>1</sup>, Christine Kallmayer<sup>1</sup>, Hans Walter<sup>3</sup>, Tanja Braun<sup>1</sup>, Bernd Michel<sup>1</sup>, Herbert Reichl<sup>3</sup>. <sup>1</sup>Fraunhofer IZM, <sup>2</sup>Amic Berlin, <sup>3</sup>TU Berlin

**Microstrip line parameters causing signal degradation**

Tomas Blecha, University of West Bohemia

**Accurate 3D modelling and simulation of advanced packages and vertical stacked dice**

Norocel Codreanu, Ciprian Ionescu, Paul Svasta, Ioan Plotog, Politehnica University of Bucharest, UPB-CETTI

**Multi Physics Modelling of the Electrodeposition Process**

Nadia Strusevich, Michael Hughes, Georgi Djambazov, Chris Bailey, University of Greenwich

**Challenge in modelling biofluids in microchannels**

Xiangdong Xue, Mayur Patel, Chris Bailey, University of Greenwich

**Application of genetic algorithm in numerical multi-objective optimization of ceramic capacitors**

Lukasz Dowhan<sup>1</sup>, Artur Wymyslowski<sup>1</sup>, Jan Felba<sup>1</sup>, Steffen Wiese<sup>2</sup>, Klaus-Jurgen Wolter<sup>2</sup>. <sup>1</sup>Wroclaw University of Technology, <sup>2</sup>Technical University Dresden

**Integration Issues in the Development of a Modelling and Simulation Tool for Low Volume High-Complexity Electronics Manufacture**

Diana M. Segura Velandia, Andrew A. West, Paul P. Conway, Radmehr Monfared, Lina A. M. Huertas Quintero, Antony R. Wilson, Loughborough University

**Degradation Mechanism of Ag-Epoxy Conductive Adhesive Joints by Heat and Humidity Exposure**

Sun Sik Kim<sup>1</sup>, Keun Soo Kim<sup>1</sup>, Katsuaki Suganuma<sup>1</sup>, Hirokazu Tanaka<sup>2</sup>, <sup>1</sup>Osaka University, <sup>2</sup>ESPEC Corporation

**Application of FPGA units in combined temperature cycle and vibration reliability tests of lead-free interconnections**

Przemyslaw Matkowski<sup>1</sup>, Krzysztof Urbanski<sup>1</sup>, Rafal Zawierta<sup>1</sup>, Jan Felba<sup>1</sup>, Michael Pecht<sup>2</sup>, Abhijit Dasgupta<sup>2</sup>. <sup>1</sup>Wroclaw University of Technology, Faculty of Microsystem Electronics and Photonics, <sup>2</sup>CALCE Electronic Products and Systems Center

**Coffin Manson Testing of Isotropic Conductive Adhesives**

Koteru Rajashekar Reddy, Portland State University

### Session Tu-P-9 Advanced Packaging : Embedded Die and Reconstructed Wafer

**Assembly of Ultra-Thin Chip Packages (UTCPs) for Enhanced Flexibility of Flexible Displays**

Jonathan Govaerts, Jan Vanfleteren, TFCG Microsystems - Ugent/IMEC

**Industrial and Technical Aspects of Chip Embedding Technology**

Andreas Ostmann<sup>1</sup>, Dionysios Manassis<sup>1</sup>, Johannes Stahr<sup>2</sup>, Maarten Cauwe<sup>3</sup>, Johan De Baets<sup>3</sup>, <sup>1</sup>Fraunhofer IZM, <sup>2</sup>AT&S, <sup>3</sup>IMEC

**"GlassPack" – Photonic Packaging using thin glass foils for Electrical-Optical Circuit Boards (EOCB) and sensor modules**

Henning Schröder, Norbert Arndt-Staufenbiel, Lars Brusberg, Fraunhofer IZM

**Reliability and Thermal Assessment of Stacked Chip-on-Metal Panel Level Package with Fan-Out Capability**

Hsiu-Ping Wei, Ming-Chih Yew, Chung-Jung Wu, Kuo-Ning Chiang, National Tsing Hua University, Taiwan

### Session Tu-P-10 New Materials and Processes : Thermal Applications

**Nano-scaled functional layer for current and heat transportation in electronics packaging**

Matthias Heimann<sup>1</sup>, Schoenecker Andreas<sup>2</sup>, Ingolf Endler<sup>2</sup>, Frank Meissner<sup>2</sup>, Klaus-Jurgen Wolter<sup>1</sup>. <sup>1</sup>Technische Universität Dresden, Electronics Packaging Laboratory Dresden, Germany, <sup>2</sup>Fraunhofer IKTS Dresden, Germany

**An investigation of thick-film materials for temperature and pressure sensors on self-constrained LTCC substrates**

Marko Hrovat<sup>1</sup>, Darko Belavic<sup>2</sup>, Hana Ursic<sup>1</sup>, Jaroslav Kita<sup>3</sup>, Janez Holc<sup>1</sup>, Silvo Drnovsek<sup>1</sup>, Jena Cilensek<sup>1</sup>, Marija Kosec<sup>1</sup>, Ralf Moos<sup>3</sup>. <sup>1</sup>Jozef Stefan Institute, <sup>2</sup>HIPOT-RR, <sup>3</sup>University of Bayreuth

**High-speed Indium Electrodeposition: Efficient, Reliable TIM Technology**

Szöcs Edit, Schwager Felix, Toben Michael, Brese Nathaniel, Rohm and Haas Electronic Materials

**Overview of Recent Progress of Thermal Interface Materials**

Johan Liu, Björn Carlberg, Teng Wang, Masahiro Inoue, SMIT Center and BioNano Systems Laboratory, Dept. of Microtechnology and Nanoscience, Chalmers University of Technology, Sweden

### Session Tu-P-11 Modelling, Simulation and Design : Simulation and DFR 2

**Thermo-Mechanical Pre-Optimisation of Radar Sensor Design by Means of FEA and microDAC Measurements**

Johann-Peter Sommer, Bernd Michel, Fraunhofer IZM

### **Efficient and Accurate Neural Network-Based Macro-models for Spiral Inductors**

Abby Ilumoka, Raghuvveer Srinivasan, University of Hartford

### **Design and Performance of Metal Conductors for Stretchable Electronic Circuits**

Mario Gonzalez<sup>1</sup>, Fabrice Axisa<sup>2</sup>, Eva De Leersnyder<sup>2</sup>, Dominique Brosteaux<sup>2</sup>, Bart Vandeveldel<sup>1</sup>, Jan Vanfleteren<sup>2</sup>, <sup>1</sup>IMEC / IPSI, <sup>2</sup>IMEC/ TFCG Microsystems

### **Prediction of Junction Temperatures of Electronic Packages with Integrated CTM+CFD Methodology**

Rohit Dev Gupta, Vinayak Eswaran, Indian Institute of Technology, Kanpur India

## **Session Tu-P-12 Manufacturing and Test Technology : Test 2**

### **Modelling and Measurement of Wire Bonding Power Interconnection**

Ivan Szendiuch<sup>1</sup>, Marek Novotny<sup>1</sup>, Jaroslav Jankovsky<sup>1</sup>, Zdenek Barton<sup>2</sup>, <sup>1</sup>Brno University of Technology, <sup>2</sup>CEDO

### **Resistors Testing by Noise, Non-Linearity and Electro-Ultrasonic Spectroscopy**

Vlasta Sedlakova, Josef Sikula, Pavel Tofel, Milos Chvatal, Brno University of Technology

### **Test Pattern Generation for Crosstalk Faults in DSM chips using Genetic Algorithm**

Kishore Kumar Duganapalli, Ajoy Kumar Palit, Walter Anheier, University of Bremen

### **X-ray nanoCT of electronic components: Visualizing of internal 3D-Structures with Submicrometer Resolution**

André Egbert, phoenix|x-ray Systems + Services

## **Session Tu-P-13 Power Electronics: Thermal**

### **Al<sub>2</sub>O<sub>3</sub> filled thermoplastics for cooling of power inductors**

Sven Egelkraut<sup>1</sup>, Christoph Heinle<sup>2</sup>, Andreas Schletz<sup>3</sup>, Bernd Eckardt<sup>3</sup>, Martin März<sup>3</sup>, Heiner Ryssel<sup>1</sup>, <sup>1</sup>Chair of Electron Devices - University of Erlangen-Nuremberg, <sup>2</sup>Chair of Polymer Technology - University of Erlangen-Nuremberg, <sup>3</sup>Fraunhofer Institute for Integrated Systems and Device Technology

### **Reliability of die attached AlN-DBC module using Zn-Sn high temperature lead free solders**

Seong-Jun Kim, Do-Seop Kim, Keun-Soo Kim, Katsuaki Sugauma, Osaka University

### **High temperature behaviour and reliability of Al-Ribbon for automotive application**

Tobias Mueller, Eugen Milke, W. C. Heraeus GmbH

### **Characteristics of high-voltage capacitors when operating in high temperature environments**

Nam Nguyen-Quang, Martin Foster, David Stone, The University of Sheffield

## **Session Tu-P-14 Electronics System Integration for Healthcare : Processes and Devices**

### **Embedded Test & Health Monitoring Strategies for Bio-Fluidic Microsystems**

H. Liu<sup>1</sup>, A. Richardson<sup>1</sup>, T. Ryan<sup>2</sup>, C. Pickering<sup>3</sup>, <sup>1</sup>University of Lancaster, <sup>2</sup>EPIGEM Ltd, <sup>3</sup>QinetiQ

### **Integrated Biomedical Device For Blood Preparation**

Maiwenn Kersaudy-Kerhoas<sup>1</sup>, Xiangdong Xue<sup>2</sup>, Mayur Patel<sup>2</sup>, Resham Dhariwal<sup>1</sup>, Marc P.Y. Desmulliez<sup>1</sup>, <sup>1</sup>MicroSystems Engineering Centre, Heriot-Watt University, <sup>2</sup>University of Greenwich

### **Micro Ribbon Cable Bonding for an Implantable Device**

Kristin Imenes<sup>1</sup>, Knut Aasmuntveit<sup>1</sup>, Pablo Moreno<sup>2</sup>, J.R. Vázquez de Aldana<sup>2</sup>, <sup>1</sup>Vestfold University College, Faculty of Science and Engineering, Horten, Norway, <sup>2</sup>Servicio Láser, Universidad de Salamanca, Salamanca, Spain

### **Design and fabrication of a miniaturized three-axis accelerometer for measuring heart wall motion**

Craig Lowrie<sup>1</sup>, Marc Desmulliez<sup>1</sup>, Lars Hoff<sup>2</sup>, Ole Jakob Elle<sup>3</sup>, Erik Fosse<sup>3</sup>, <sup>1</sup>Microsystems Engineering Centre (MISEC), Heriot-Watt University, Scotland, <sup>2</sup>Faculty of Science and Engineering, Vestfold University College, Horten, Norway, <sup>3</sup>The Interventional Centre, Rikshospitalet University Hospital, Oslo, Norway

## **Coffee Break**

## **Session Tu-P-15 Poster Session : Reliability and Technology for Micro and Nano Systems**

### **Ni Underlayer Efficiency for Whisker Mitigation in IC Packaging**

Jeffrey C.B. Lee Lee, IST-Integrated Service Technology

### **A Micro-fabricated Current Sensor for Arc Fault Detection of Aircraft Wiring**

Brian G. Moffat<sup>1</sup>, Marc P.Y. Desmulliez<sup>1</sup>, Alistair Sutherland<sup>2</sup>, David Flynn<sup>1</sup>, <sup>1</sup>Heriot-Watt University, <sup>2</sup>Ultra electronics BCF

### **Material Characterization of Organic Packaging Materials to Increase the Accuracy of FEM Based Stress Analysis**

Bjoern Boehme, Mike Roellig, Klaus-Juergen Wolter, Technische Universität Dresden, Electronics Packaging Laboratory, Dresden, Germany

### **Embedded health monitoring Strategies for Aircraft Wiring Systems**

Z. Xu<sup>1</sup>, S. Saha<sup>1</sup>, D. Koltsov<sup>1</sup>, A. Richardson<sup>1</sup>, B. Honary<sup>1</sup>, A. Sutherland<sup>2</sup>, J. Hannu<sup>3</sup>, M. Desmulliez<sup>4</sup>, <sup>1</sup>Lancaster University, <sup>2</sup>University of Oulu, <sup>3</sup>Ultra Electronics -BCF, <sup>4</sup>Heriot-Watt University

### **Brittle Fracture of Solder Joints**

Vladimir Igoshev<sup>1</sup>, Bev Christian<sup>2</sup>, <sup>1</sup>SENTEC, <sup>2</sup>Research in Motion

## **Reliability Of Lead Free Solder Sac 305 For Chip Components Depending On Various Factors**

*Olga Russkikh, Josef ŠAndera, Brno University of Technology*

### **Corrosion of lead-free and SnPb solder alloys**

*Ling Zou, Chris Hunt, National Physical Laboratory*

### **Temperature-dependent behaviour of thin film by microtensile testing**

*Han Seungwoo<sup>1</sup>, Kim Taeok<sup>2</sup>, Lee Hakjoo<sup>1</sup>, Lee Hyunwoo<sup>2</sup>.<sup>1</sup>Korea Institute of Machinery & Materials, <sup>2</sup>Pusan National University*

### **Data Visualization in a Fast Data Acquisition System for Long-term Reliability Tests of Microelectronic Interconnections**

*Rafal Zawierta, Krzysztof Urbanski, Przemyslaw Matkowski, Jan Felba, Faculty of Microsystem Electronics and Photonics/Wroclaw University of Technology*

### **Characterization of mechanical-electrical properties of nickel film by plating**

*Han Seungwoo, Lee Sangjoo, Lee Hakjoo, Korea Institute of Machinery & Materials*

## **Session Tu-P-16 Advanced Packaging : RF Integration and Packaging**

### **Integration Of Precision Passive Components On Silicon For Performance Improvements And Miniturization**

*Umesh Sharma, Harry Gee, Danny Liou, Philip Holland, Rong Liu, California Micro Devices*

### **Compact RF-Filter-Modules with lumped elements in LTCC for applications up to 10GHz**

*Rubén Perrone, Jens Müller, TU Ilmenau / BMBF Center for Innovation Competence MacroNano®*

### **Embedded Duplexer Implementation for WiMAX Front-end module with organic package substrate**

*KyungO Kim, Taeui Kim, Hongwon Kim, Samsung Electro-Mechanics*

### **RF Performance of ACA Flip Chip Joints for CPW Transmission Lines**

*Xu Wang<sup>1</sup>, Xia Zhang<sup>2</sup>, Johan Liu<sup>3</sup>, Zhaonian Cheng<sup>2</sup>, Yan Zhang<sup>1</sup>.<sup>1</sup>Shanghai University, China, <sup>2</sup>Chalmers University of Technology, Sweden, <sup>3</sup>Shanghai University & Chalmers University of Technology*

## **Session Tu-P-17 New Materials and Processes : Bonding, Plating and Fabrication I**

### **Fabrication of Ag Micromaterials by Utilizing Stress-induced Migration**

*Masumi Saka, Makoto Yasuda, H. Tohmyoh, Nobuhiro Settsu, Tohoku University*

### **Laser Transfer Processing and Integration of Ferroelectric Films for System in Package Applications**

*S. J. Milne<sup>1</sup>, C. James<sup>1</sup>, R. E. Miles<sup>1</sup>, T. Chakraborty<sup>1</sup>, H. Harrington<sup>1</sup>, A. P. Brown<sup>1</sup>, C. James<sup>1</sup>, T. Comyn<sup>1</sup>, B. Xu<sup>2</sup>.<sup>1</sup>University of Leeds, <sup>2</sup>Palo Alto Research Center*

### **Comparative Performance of Single Layer and Multilayer Microwave Filters including the Influence of the Fabrication Process**

*Wesam Ali, Chunwei Min, Charles Free, ATII University of Surrey*

### **Impact of RoHS/WEEE – On effective recycling- Electronics System Integration**

*Lafir Ali, Yan-Cheong CHAN, City University of Hong Kong/EPA centre*

## **Session Tu-P-18 Modelling, Simulation and Design : Simulation and DFR 3**

### **A Comprehensive FEM Simulation Study on DDR5 Memory Modules Subjected to Thermo-mechanical and Mechanical Loads**

*Przemyslaw Gromala, Qimonda Dresden GmbH & Co. OHG*

### **Optimizing coplanar wave guide to microstripline transition with the help of the low pass filter theory in the mm wave domain**

*Joseph Romen Cubillo, Jean Gaubert, Sylvain Bourdel, IM2NP*

### **Thermal Optimization of 3D Micro-contacts Using DOE and CFD Analysis**

*Nadezhda Kafadarova<sup>1</sup>, Anna Andonova<sup>2</sup>, Svetozar Andreev<sup>2</sup>, Radosvet Arnaudov<sup>2</sup>.<sup>1</sup>Technical University Sofia, Plovdiv branch, <sup>2</sup>Technical University Sofia*

### **3D Hybrid Capacitance Model for Angular Vertical Comb Drives**

*Denis Jung, Thomas Klose, Thomas Graßhoff, Thilo Sandner, Harald Schenk, Fraunhofer Institute for Photonic Micro Systems*

## **Session Tu-P-19 Manufacturing and Test Technology : Technology**

### **RF Multi-DUT Testing Technology for RF WLP**

*Hyunho Kim, Samsung Electro-Mechanics*

### **Advanced microwave oven for rapid curing of encapsulant**

*K. I. Sinclair<sup>1</sup>, T. Tilford<sup>2</sup>, G. Goussetis<sup>1</sup>, C. Bailey<sup>2</sup>, M. P. Y. Desmulliez<sup>1</sup>, A. K. Parrott<sup>2</sup>, A. J. Sangster<sup>1</sup>.<sup>1</sup>MicroSystems Engineering Centre (MISEC), Heriot-Watt University, Edinburgh, UK, <sup>2</sup>Centre for Numerical Modelling and Process Analysis (CNMPA), University of Greenwich, UK*

### **Global joint effort to solve electronics supply chain technology issues**

*Ruben Bergman<sup>1</sup>, Paul Collander<sup>2</sup>, Marshall Andrew<sup>1</sup>.<sup>1</sup>High Density Packaging User Group, <sup>2</sup>Poltronic*

### **Wettability effects of immersion tin surface finishes with lead free solder**

*Thomas Hetschel<sup>1</sup>, Fritz Phillipp<sup>2</sup>, Klaus-Jürgen Wolter<sup>3</sup>.<sup>1</sup>Robert Bosch GmbH, Stuttgart, Germany, <sup>2</sup>Max Planck Institute for Metals Research, Germany, <sup>3</sup>Electronic Packaging Laboratory, Dresden University of Technology, Germany*

## Session Tu-P-20 Power Electronics : Applications

### High Power Batteries for Maritime Applications

*Marcelo Gutierrez, Delft Technical University*

### Intelligent Power Control using System-on-Chip Devices

*Gabriel Chindris, Dan Pitica, Marius Muresan, Technical University of Cluj-Napoca*

### The Design, Modeling and Experimental Characterization of a Microinductor for Future DC-DC Power Converters

*David Flynn<sup>1</sup>, Christopher Bailey<sup>2</sup>, Marc Desmulliez<sup>1</sup>, Hua Lu<sup>2</sup>, <sup>1</sup>Heriot Watt University, <sup>2</sup>University of Greenwich*

### Flip chip based packaging solution for high current driver chips used in automotive applications

*Bart Vandeveldel<sup>1</sup>, Bjorn Vandecasteele<sup>1</sup>, Guy Brizar<sup>2</sup>, Daniel Vanderstraeten<sup>2</sup>, Eddy Blansaer<sup>2</sup>, <sup>1</sup>IMEC, <sup>2</sup>AMIS*

## Session Tu-P-21 Assembly of Alternative Energy Sources

### Novel Thick-Film Piezoceramic Micro-Generators Based on Free-Standing Structures

*Neil Maurice White, Nicholas Robert Harris, Swee Leong Kok, Michael John Tudor, University of Southampton*

### Study of Wire Electrolytic-Spark hybrid machining of Silicon Solar Wafer and surface characteristics

*Wei Wang<sup>1</sup>, Ndy Ekere<sup>2</sup>, Yinhui Huang<sup>1</sup>, Zhengxun Liu<sup>1</sup>, Zhidong Liu<sup>1</sup>, Zongjun Tian<sup>1</sup>, <sup>1</sup>Nanjing University of Aeronautics and Astronautics, China, <sup>2</sup>University of Greenwich at Medway, UK*

### Effect of plasticizers on low molecular weight PVC-Li2SO4 based polymer electrolytes for rechargeable lithium ion polymer batteries.

*Ramesh T.Subramaniam, Universiti Tunku Abdul Rahman, Faculty of Engineering and Science, Setapak, Kuala Lumpur, Malaysia*

### Mixed Thick-/Thin Film Thermoelectric Microgenerators

*Piotr Markowski, Andrzej Dziedzic, Eugeniusz Prociow, Wroclaw University of Technology*

## Plenary Special Session “Greening the Blue Planet”

- “Electronics, Energy, and The Environment”, Dr Harry K Charles Jr., Department Head, The Johns Hopkins University, Baltimore, USA
- "Is there a Green Light for our Nuclear Future?". Professor David Williams, Emeritus Professor, University of Cardiff
- "Future Parks in Future Climates - scalable solutions", Paul Sinnadurai, Ecologist of the Brecon Beacons, Wales
- "Interdependence of Marine Ecosystems and Climate Change", Emily Lewis-Brown, Marine Climate Change Officer, WWF

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## Exhibitors' Reception—Exhibition Hall

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